

A04822A

30V Dual N-channel MOSFET

General Description

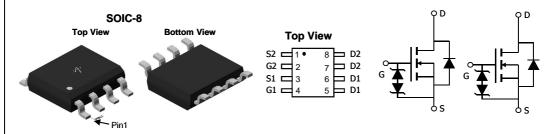
The AO4822A uses advanced trench technology to provide excellent $R_{\rm DS(ON)}$ and low gate charge. This device is suitable for use as a load switch or in PWM applications.

Product Summary

 $\begin{array}{lll} V_{DS} & 30V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 8A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & <19 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 4.5V) & <26 m\Omega \end{array}$

ESD Protected 100% UIS Tested 100% R_g Tested





Absolute Maximum Ratings T _A =25℃ unless otherwise noted							
Parameter		Symbol	Maximum	Units			
Drain-Source Voltage		V _{DS}	30	V			
Gate-Source Voltage		V _{GS}	±20	V			
Continuous Drain	T _A =25℃	ı	8				
Current	T _A =70℃	'D	6.5	Α			
Pulsed Drain Current ^C		I _{DM}	48				
Avalanche Current ^C		I _{AS} , I _{AR}	19	Α			
Avalanche energy L=0.1mH ^C		E _{AS} , E _{AR}	18	mJ			
	T _A =25℃	P _D	2	W			
Power Dissipation ^B	T _A =70℃	l D	1.3				
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	C			

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	D	48	62.5	℃/W			
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	74	90	C/W			
Maximum Junction-to-Lead	Steady-State	$R_{\theta JL}$	32	40	C/W			



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units		
STATIC PARAMETERS									
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		30			V		
I _{DSS}	Zero Gate Voltage Drain Current	V_{DS} =30V, V_{GS} =0V				1	μА		
	Zero Gate Voltage Drain Gurrent		T _J =55℃			5	μΑ		
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±20V				10	μΑ		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$	1.2	1.8	2.4	V			
$I_{D(ON)}$	On state drain current	V_{GS} =10V, V_{DS} =5V		48			Α		
		V_{GS} =10V, I_D =8A			15.5	19	mΩ		
R _{DS(ON)}	Static Drain-Source On-Resistance		T _J =125℃		21	25	11122		
		V_{GS} =4.5V, I_D =6A			18.5	26	mΩ		
g _{FS}	Forward Transconductance	V_{DS} =5V, I_{D} =8A			30		S		
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.75	1	V		
I _S	Maximum Body-Diode Continuous Current					2.5	Α		
DYNAMIC	PARAMETERS								
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =15V, f=1MHz		600	740	888	pF		
Coss	Output Capacitance			77	110	145	pF		
C _{rss}	Reverse Transfer Capacitance			50	82	115	pF		
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		0.5	1.1	1.7	Ω		
SWITCHII	NG PARAMETERS								
Q _g (10V)	Total Gate Charge	V _{GS} =10V, V _{DS} =15V, I _D =8A		12	15	18	nC		
Q _g (4.5V)	Total Gate Charge			6	7.5	9	nC		
Q_{gs}	Gate Source Charge			2	2.5	3	nC		
Q_{gd}	Gate Drain Charge			2	3	5	nC		
t _{D(on)}	Turn-On DelayTime	V_{GS} =10V, V_{DS} =15V, R_L =1.8 Ω , R_{GEN} =3 Ω			5		ns		
t _r	Turn-On Rise Time				3.5		ns		
t _{D(off)}	Turn-Off DelayTime				19		ns		
t _f	Turn-Off Fall Time				3.5		ns		
t _{rr}	Body Diode Reverse Recovery Time	I _F =8A, dI/dt=500A/μs		6	8	10	ns		
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =8A, dl/dt=500A/μs		14	18	22	nC		

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The value in any given application depends on the user's specific board design. B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using \leqslant 10s junction-to-ambient thermal resistance.

COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS ARE NOT AUTHORIZED. AOS DOES NOT ASSUME ANY LIABILITY ARISING OUT OF SUCH APPLICATIONS OR USES OF ITS PRODUCTS. AOS RESERVES THE RIGHT TO IMPROVE PRODUCT DESIGN, FUNCTIONS AND RELIABILITY WITHOUT NOTICE.

Rev 4: November 2010 Page 2 of 6 www.aosmd.com

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150° C. Ratings are based on low frequency and duty cycles to keep initialT_{.1}=25° C.

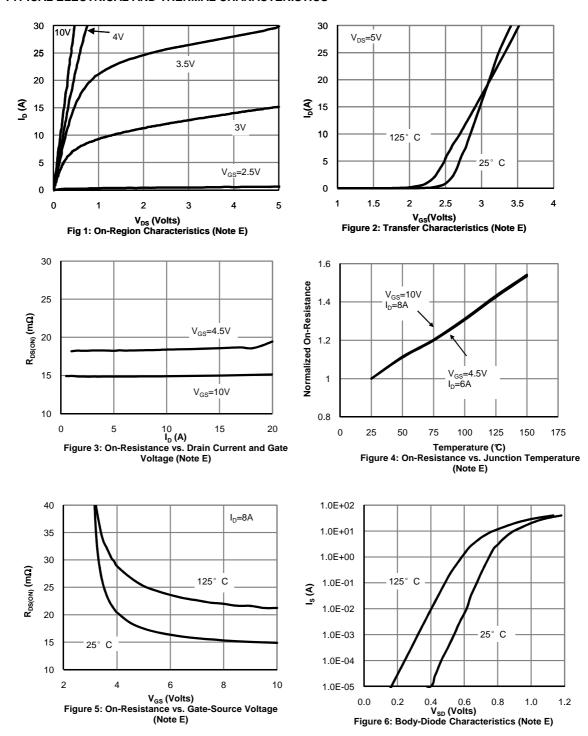
D. The $R_{\theta JA}$ is the sum of the thermal impedence from junction to lead $R_{\theta JL}$ and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, assuming a maximum junction temperature of $T_{J(MAX)}=150^\circ$ C. The SOA curve provides a single pulse rating.



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

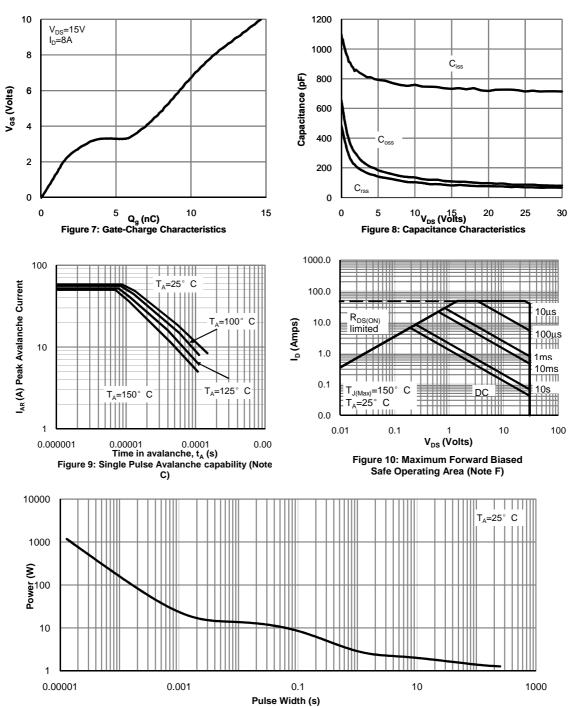
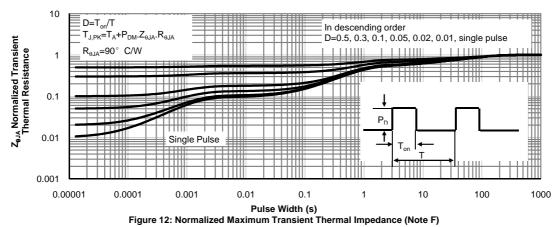


Figure 11: Single Pulse Power Rating Junction-to-Ambient (Note F)

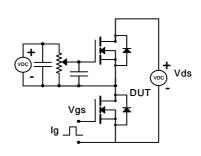


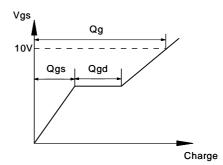
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



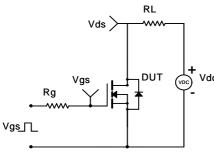


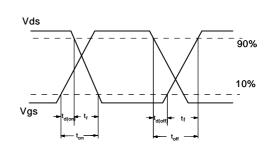
Gate Charge Test Circuit & Waveform



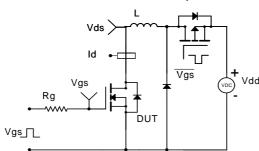


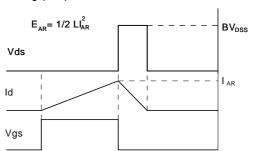
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

